Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/596,590	ONOUE ET AL.
Examiner	Art Unit
Karuna P. Reddy	1713

SEARCHED				
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH N (INCLUDING SEARC		)
	DATE	EXMR
EAST, Inventor's Search	7/11/2007	KR
524/800,801	7/12/2007	KR
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